# **SMD** Power Inductor

BSMA1050S-Series(N)-D

		ECN HIST	ORY LIST		
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN
1.0	18/03/30	新發行	羅宜春	梁周虎	卜文娟
備					
注					

## 1. Features

- 1. Shielded construction.
- 2. Capable of corresponding high frequency
- 3. Low loss realized with low DCR.
- 4. High performance (Isat) realized by metal dust core.
- 5. Ultra low buzz noise, due to composite construction.
- 6. 100% Lead(Pb)-Free and RoHS compliant.

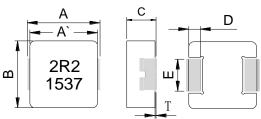
## 2. Applications

- 1. DC/DC converters in distributed power systems.
- 2. DC/DC converter for Field Programmable Gate Array(FPGA).
- 3. Battery powered devices.
- 4. Thin type on-board power supply module for exchanger.

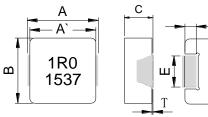
5. VRM for server.

- 6. High current, low profile POL converters.
- 7. PDA/notebook/desktop/server and battery powered devices.

## 3. Dimensions



leadframe

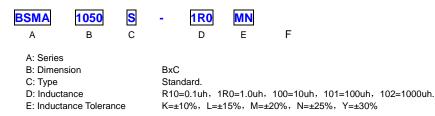


### non-leadframe

Series	Α	A`	В	С	D	Т	Е	Inductance	
							2.5±0.3	0.68~1.50uH among	No
BSMA1050	11.0±0.5	10.0±0.5	10.0±0.3	4.8±0.2	2.0±0.3	0~0.2	3.0±0.3	0.47uH and below 2.20uH and above	INC
Unit:mm									-

D

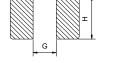
## 4. Part Numbering





## **Recommend PC Board Pattern**





L(mm)	G(mm)	H(mm)					
12.5	5.4	3.5					
Jote: 1. The above PCB layout reference only 2. Recommend solder paste thickness							
0.15mm and above.							

# 5. Specification

Part Number	Inductance L0 A(uH) ±20%	Curre	Rating Int DC s.(A)	Curre	ration ent DC t. (A)	DCR (mΩ)Typ	DCR (mΩ)Max	Туре
	12070	Тур	Max	Тур	Max			
BSMA1050S-R36MN	0.36	34.0	30.0	52.0	46.0	0.82	0.92	non-leadframe
BSMA1050S-R47MN	0.47	33.0	29.0	46.0	40.0	1.15	1.32	non-leadframe
BSMA1050S-R68MN	0.68	28.0	25.0	35.0	32.0	1.6	1.9	non-leadframe
BSMA1050S-1R0MN	1.00	25.0	23.0	33.0	30.0	2.6	3.0	non-leadframe
BSMA1050S-1R5MN	1.50	23.0	21.0	27.0	24.0	3.4	3.8	non-leadframe
BSMA1050S-2R2MN	2.20	19.5	17.5	20.0	18.0	5.1	5.6	leadframe
BSMA1050S-3R3MN	3.30	17.0	15.0	17.5	15.5	8.1	9.1	leadframe
BSMA1050S-4R7MN	4.70	15.0	13.0	16.0	14.0	9.3	10.5	leadframe
BSMA1050S-5R6MN	5.60	13.0	11.0	15.0	12.5	12.8	14.4	leadframe
BSMA1050S-6R8MN	6.80	12.0	10.0	14.0	12.0	15.0	17.3	leadframe
BSMA1050S-100MN	10.0	7.6	7.2	13.0	11.0	18.9	21.8	leadframe
BSMA1050S-101MN	100	2.2	2.0	2.8	2.4	242.0	290.0	leadframe

Note:

1. Test frequency : Ls : 100KHz /1.0V.

2. All test data referenced to  $25^\circ\!\!\mathbb{C}$  ambient.

3. Testing Instrument(or equ) : L: HP4284A,CH11025,CH3302,CH1320,CH1320S LCR METER / Rdc:CH16502,Agilent33420A MICRO OHMMETER.

4. Heat Rated Current (Irms) will cause the coil temperature rise approximately  $\ {}_{\Delta}T$  of 40°C

5. Saturation Current (Isat) will cause L0 to drop approximately 30%.

6. The part temperature (ambient + temp rise) should not exceed 125°Cunder worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.

7. Special inquiries besides the above common used types can be met on your requirement.

# 6. Material List



NO	Items	Materials
1	Core	Alloy Powder .
2	Wire	Polyester Wire or equivalent. (AIW ,220℃ CLASS)
3	Clip	100% Pb free solder(Ni+SnPlating)
4	Ink	Halogen-free ketone

4	non-leadframe
Marking	
3	
1 2	

NO	Items	Materials
1	Core	Alloy Powder .
2		Polyester Wire or equivalent. (AIW ,220°C CLASS)
3	Solder	100% Pb free solder
4	Ink	Halogen-free ketone

# 7. Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125°C (Including self - temperature rise)	
Storage temperature	110~+40℃,50~60%RH (Product without taping) 240~+125℃ (on board)	
Electrical Performance Te	est	
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.
DCR		CH16502, Agilent 33420A Micro-Ohm Meter.
Saturation Current (Isat)	Approximately	Saturation DC Current (Isat) will cause L0 to drop $\triangle$ L(%)
Heat Rated Current (Irms)	Approximately $ riangle T40^\circ C$	Heat Rated Current (Irms) will cause the coil temperature rise △T(℃). 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer
Reliability Test	÷	
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDECJ-STD-020DClassification Reflow Profiles) Temperature : 125±2°C(Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs.
Load Humidity		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDECJ-STD-020DClassification Reflow Profiles) Humidity: $85\pm2\%$ R.H, Temperature: $85^{\circ}C\pm2^{\circ}C$ Duration: 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs.
Moisture Resistance	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDECJ-STD-020DClassification Reflow Profiles) 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs. 3. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs,keep at $25°C$ for 2 hrs then keep at $-10°C$ for 3 hrs 4. Keep at $25°C$ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1–2 hrs.
Thermal shock		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDECJ-STD-020DClassification Reflow Profiles) Condition for 1 cycle Step1 : -40±2°C 30±5min Step2 : 25±2°C ≤0.5min Step3 : 125±2°C 30±5minNumber of cycles : 500 Measured at room femprature after placing for 24±2 hrs.
Vibration		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDECJ-STD-020DClassification Reflow Profiles) Oscillation Frequency: 10~2K~10Hz for 20 minutes Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations),

## <u>Bullwill</u>

Item	Performance				Test	Cond	ition	
Bending	Appearance ∶ No damage. Imoedance : within±15% of initial value	vithin±15% of initial value  vithin±10% of initial value  Velocity    vithin±10% of initial value  Type  Peak  Normal  Velocity    ts5% of initial value and shall not  (g's)  (ms)  Velocity  Change				012mm):40 n	0x100x1.2mm	
Chask	Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not							
Shock	exceed the specification value					-		
			Lead	50		11	Half-sine	11.3
Solder ability	More than 95% of the terminal electrode should be covered with solder。	Preheat: 150℃,60sec.。 Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5℃ ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘ Depth: completely cover the termination						
Resistance to Soldering Heat			empera	ature(°C)	Time(s)	ramp/ir and eme	perature mmersion ersion rate	Number of heat cycles
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Pre J-S Wit tes dev sec				the device to be g)to the side of a plied for 60 +1		
						pre	55 1001	shear force

Note : When there are questions concerning measurement result : measurement shall be made after  $48 \pm 2$  hours of recovery under the standard condition.

## 8. Soldering and Mounting

#### (1) Soldering

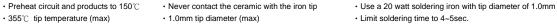
Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. Bullwill terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

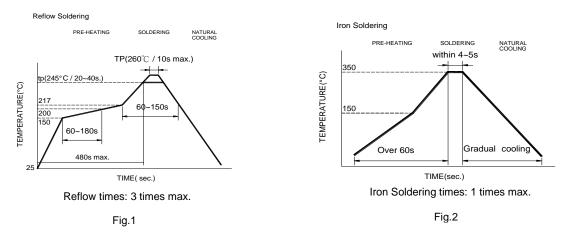
#### (2) Solder re-flow:

Recommended temperature profiles for re-flow soldering in Figure 1.

#### (3) Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.



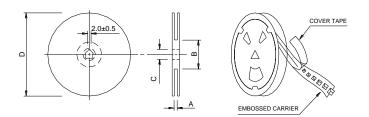


## 9. Friendly reminder

- (1) When there are questions concerning measurement result : measurement shall be made after 48  $\pm$  2 hours of recovery under the standard condition
- (2) This power choke coil itself does not have any protective function in abnormal condition such as overload, short-circuit and open-circuit conditions, etc. Therefore, it shall be confirmed as the end product that there is no risk of smoking, fire, dielectric withstand voltage, insulation resistance, etc. in abnormal conditions to provide protective devices and/or protection circuit in the end product.
- (3) When this power choke coil was used in a similar or new product to the original one, sometimes it might not be able to satisfy the specifications due to different condition of use.
- (4) Dielectric withstanding test with higher voltage than specific value will damage insulating material and shorten its life.
- (5) This power choke coil must not be used in wet condition by water, coffee or any liquid because insulation strength becomes very low in this condition.
- (6) Please consult our company to confirm the reliability of the process required to wash or use or exposure to a chemical solvent used in this product. PCB washing tested to MIL-STD-202 Method. Use only alcohol to wash the PCB and dry it off immediately (Marking will be washed away if using alcohol).

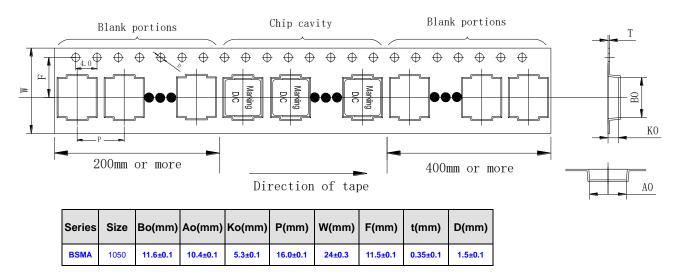
## **10. Packaging Information**

## (1) Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
13"x24mm	24.4+2/-0	100±2	13+0.5/-0.2	330

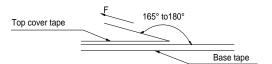
### (2) Tape Dimension



#### (3) Packaging Quantity

BSMA	1050
Chip / Reel	500
Inner box	1000
Carton	4000

#### (4) Tearing Off Force

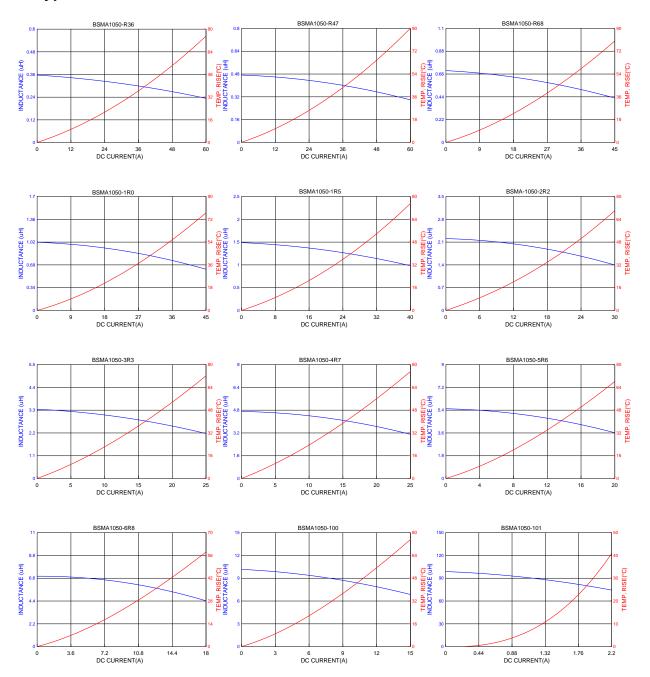


The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-D-2008 of 4.11 stadnard).

Room Temp.	Room Humidity	Room atm	Tearing Speed
(°C)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	

#### Application Notice

- Storage Conditions
  - To maintain the solderability of terminal electrodes:
  - 1. TBullwill products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
  - 2. Temperature and humidity conditions: Less than 40°C and 60% RH.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
  - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- The use of tweezers or vacuum pick up is strongly recommended for individual components.
  Bulk handling should ensure that abrasion and mechanical shock are minimized.



# **11. Typical Performance Curves**